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| Notice of References Cited | Application/Control No. 09/805,827 | Applicant(s)/Patent Under Reexamination HUNGERBUEHLER ET AL. | |
| | Examiner Kim T. Huynh | Art Unit 2112 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-2002/0080811 A1 | 06-2002 | Wetzel et al. | 370/442 |
| | B | US-6,473,822 B1 | 10-2002 | Nakamatsu et al. | 710/300 |
| | C | US-6,493,407 B1 | 12-2002 | Sheafor et al. | 375/356 |
| | D | US-6,272,574 B1 | 08-2001 | Hamada, Hiroshi | 710/301 |
| | E | US-6,611,905 B1 | 08-2003 | Grundon et al. | 711/167 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | Q | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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